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SN54LVC00A, SN74LVC00A

SCAS279R - JANUARY 1993-REVISED FEBRUARY 2016

SNx4LVC00A Quadruple 2-Input Positive-NAND Gates

1 Features

- Operate From 1.65 V to 3.6 V
- Specified From -40°C to 85°C, -40°C to 125°C, and -55°C to 125°C
- Inputs Accept Voltages to 5.5 V
- Max t_{pd} of 4.3 ns at 3.3 V
- Typical V_{OLP} (Output Ground Bounce) < 0.8 V at V_{CC} = 3.3 V, T_A = 25°C
- Typical V_{OHV} (Output V_{OH} Undershoot) > 2 V at V_{CC} = 3.3 V, T_A = 25°C
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- On Products Compliant to MIL-PRF-38535, All Parameters Are Tested Unless Otherwise Noted. On All Other Products, Production Processing Does Not Necessarily Include Testing of All Parameters.
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model
 - 200-V Machine Model
 - 1000-V Charged-Device Model

2 Applications

- **AV Receivers**
- Audio Docks: Portable

Tools &

Software

- Blu-ray Players and Home Theater
- MP3 Players or Recorder s
- Personal Digital Assistants (PDAs) .
- Power: Telecom/Server AC/DC Supply: Single Controller: Analog and Digital
- Solid State Drives (SSDs): Client and Enterprise
- TVs: LCD, Digital, and High-Definition (HDTV) ٠
- **Tablets: Enterprise** •
- Video Analytics: Server
- Wireless Headsets, Keyboards, and Mice

3 Description

The SN54LVC00A quadruple 2-input positive-NAND gate is designed for 2.7-V to 3.6-V V_{CC} operation, and the SN74LVC00A quadruple 2-input positive-NAND gate is designed for 1.65-V to 3.6-V V_{CC} operation.

The SNx4LVC00A devices perform the Boolean function $Y = \overline{A \times B}$ or $Y = \overline{A} + \overline{B}$ in positive logic.

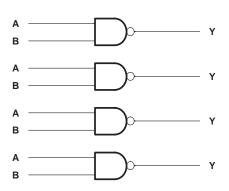
Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

PACKAGE	BODY SIZE (NOM)						
SOIC (14)	8.65 mm × 3.91 mm						
SSOP (14)	6.20 mm × 5.30 mm						
SOP (14)	10.30 mm × 5.30 mm						
TSSOP (14)	5.00 mm × 4.40 mm						
VQFN (14)	3.50 mm × 3.50 mm						
	PACKAGE SOIC (14) SSOP (14) SOP (14) TSSOP (14)						

Device Information⁽¹⁾

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Simplified Schematic





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5 Revision History

Cł	Changes from Revision Q (December 2014) to Revision R Pag			
•	Added Junction temperature row to Absolute Maximum Ratings table	4		
•	Changed statement of "open drain: to "maximum sink and source current" statement in Overview of <i>Detailed</i> <i>Description</i> section	9		
•	Deleted "open drain" from Application Information section	10		

Changes from Revision P (July 2005) to Revision Q

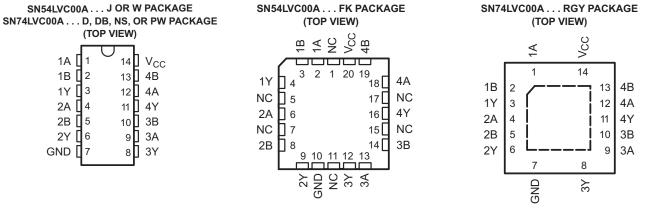
•	Added Applications, Device Information table, Pin Functions table, ESD Ratings table, Thermal Information table,	
	Typical Characteristics, Feature Description section, Device Functional Modes, Application and Implementation	
	section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and	
	Mechanical, Packaging, and Orderable Information section.	. 1
•	Deleted Ordering Information table.	1
•	Added Military Disclaimer to Features.	1

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6 Pin Configuration and Functions



NC - No internal connection

Pin Functions

PIN						
NAME	SN74LV	SN74LVC00A		SN54LVC00A		DESCRIPTION
NAME	D, DB, NS, PW	RGY	J, W	FK		
1A	1	1	1	2	1	Gate 1 input
1B	2	2	2	3	I	Gate 1 input
1Y	3	3	3	4	0	Gate 1 output
2A	4	4	4	6	I	Gate 2 input
2B	5	5	5	8	I	Gate 2 input
2Y	6	6	6	9	0	Gate 2 output
GND	7	7	7	10	—	Ground Pin
3Y	8	8	8	12		Power Pin
3A	9	9	9	13	I	Gate 4 input
3B	10	10	10	14	I	Gate 4 input
4Y	11	11	11	16	0	Gate 4 output
4A	12	12	12	18	I	Gate 3 input
4B	13	13	13	19	I	Gate 3 input
V _{CC}	14	14	14	20	0	Gate 3 output
				1		
				5		
NC				7		No Connection
NC	—	—	_	11		No Connection
				15		
				17		



Specifications 7

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		-0.5	6.5	V
VI	Input voltage range ⁽²⁾		-0.5	6.5	V
Vo	Output voltage range ⁽²⁾⁽³⁾		-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	V ₁ < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
I _O	Continuous output current			±50	mA
V _{CC}	Continuous current through GND			±100	mA
P _{tot}	Power dissipation ⁽⁴⁾⁽⁵⁾	$T_A = -40^{\circ}C$ to $125^{\circ}C$		500	mW
T _{stg}	Storage temperature range		-65	150	°C
Tj	Junction Temperature			150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed. (2)

The value of V_{CC} is provided in the Recommended Operating Conditions table. (3)

(4)

For the D package: above 70°C, the value of P_{tot} derates linearly with 8 mW/K. For the DB, NS, and PW packages: above 60°C, the value of P_{tot} derates linearly with 5.5 mW/K. (5)

7.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatia discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all $pins^{(1)}$	2000	N
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	1000	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

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7.3 Recommended Operating Conditions, SN54LVC00A

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			S	N54LV	C00A		
			-5	5°C to	125°C	UNIT	
				MIN	MAX		
V	Quantu valta na	Operating		2	3.6		
V _{CC}	Supply voltage	Data retention only		1.5		V	
V _{IH}	High-level input voltage	V _{CC} = 2.7 V to 3.6 V		2		V	
VIL	Low-level input voltage	V _{CC} = 2.7 V to 3.6 V			0.8	V	
VI	Input voltage			0	5.5	V	
Vo	Output voltage			0	V _{CC}	V	
		V _{CC} = 2.7 V			-12		
I _{OH}	High-level output current	$V_{CC} = 3 V$			-24	mA	
		V _{CC} = 2.7 V			12	~ ^	
IOL	Low-level output current	$V_{CC} = 3 V$			24	mA	

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

7.4 Recommended Operating Conditions, SN74LVC00A

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

					SN74L	VC00A			
			T _A =	25°C	–40°C to 85°C		-40°C to 125°C		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
V	Supply voltogo	Operating	1.65	3.6	1.65	3.6	1.65	3.6	V
V _{CC}	Supply voltage	Data retention only	1.5		1.5		1.5		V
		V_{CC} = 1.65 V to 1.95 V	$0.65 \times V_{CC}$		$0.65 \times V_{CC}$		$0.65 \times V_{CC}$		
VIH	High-level input voltage	$V_{\rm CC}$ = 2.3 V to 2.7 V	1.7		1.7		1.7		V
	input voltage	V_{CC} = 2.7 V to 3.6 V	2		2		2		
		V_{CC} = 1.65 V to 1.95 V		$0.35 \times V_{CC}$		$0.35 \times V_{CC}$		$0.35 \times V_{CC}$	
VIL	Low-level input voltage	V_{CC} = 2.3 V to 2.7 V		0.7		0.7		0.7	V
		$V_{CC} = 2.7 \text{ V} \text{ to } 3.6 \text{ V}$		0.8		0.8		0.8	
VI	Input voltage		0	5.5	0	5.5	0	5.5	V
Vo	Output voltage		0	V _{CC}	0	V _{CC}	0	V _{CC}	V
		V _{CC} = 1.65 V		-4		-4		-4	
	High-level	V _{CC} = 2.3 V		-8		-8		-8	0
I _{OH}	output current	$V_{CC} = 2.7 V$		-12		-12		-12	mA
		$V_{CC} = 3 V$		-24		-24		-24	
		V _{CC} = 1.65 V		4		4		4	
	Low-level	V _{CC} = 2.3 V		8		8		8	
I _{OL}	output current	$V_{CC} = 2.7 V$		12		12		12	mA
		$V_{CC} = 3 V$		24		24		24	

 All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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7.5 Thermal Information

THERMAL METRIC ⁽¹⁾		SN74LVC00A					
		D	DB	NS	PW	RGY	UNIT
		14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	86	96	76	113	47	°C/W

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

7.6 Electrical Characteristics, SN54LVC00A

over recommended operating free-air temperature range (unless otherwise noted)

			SN54LVC00A		
PARAMETER	TEST CONDITIONS	V _{cc}	–55°C to 125°C	UNIT	
			MIN MAX		
	I _{OH} = -100 μA	2.7 V to 3.6 V	$V_{CC} - 0.2$		
V	1 – 12 mA	2.7 V	2.2	V	
V _{OH}	I _{OH} = -12 mA	3 V	2.4	v	
	$I_{OH} = -24 \text{ mA}$	3 V	2.2		
	I _{OL} = 100 μA	2.7 V to 3.6 V	0.2		
V _{OL}	I _{OL} = 12 mA	2.7 V	0.4	V	
	I _{OL} = 24 mA	3 V	0.55		
li li	$V_{I} = 5.5 \text{ V or GND}$	3.6 V	±5	μA	
I _{CC}	$V_I = V_{CC} \text{ or } GND, \qquad I_O = 0$	3.6 V	10	μA	
ΔI _{CC}	One input at V_{CC} – 0.6 V, Other inputs at V_{CC} or GND	2.7 V to 3.6 V	500	μA	

7.7 Electrical Characteristics, SN74LVC00A

over recommended operating free-air temperature range (unless otherwise noted)

					S	N74LVC00A	۱			
PARAMETER	TEST CONDITIONS	V _{cc}	TA	= 25°C		–40°C to	85°C	-40°C to 1	25°C	UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
	I _{OH} = -100 μA	1.65 V to 3.6 V	$V_{CC} - 0.2$			V _{CC} – 0.2		V _{CC} - 0.3		
	$I_{OH} = -4 \text{ mA}$	1.65 V	1.29			1.2		1.05		
V _{OH}	$I_{OH} = -8 \text{ mA}$	2.3 V	1.9			1.7		1.55		V
	10 ~ 10	2.7 V	2.2			2.2		2.05		
	I _{OH} = -12 mA	3 V	2.4			2.4		2.25		
	I _{OH} = -24 mA	3 V	2.3			2.2		2		
	I _{OL} = 100 μA	1.65 V to 3.6 V			0.1		0.2		0.3	
	$I_{OL} = 4 \text{ mA}$	1.65 V			0.24		0.45		0.6	
V _{OL}	$I_{OL} = 8 \text{ mA}$	2.3 V			0.3		0.7		0.85	V
	I _{OL} = 12 mA	2.7 V			0.4		0.4		0.6	
	I _{OL} = 24 mA	3 V			0.55		0.55		0.8	
lı	$V_I = 5.5 V \text{ or GND}$	3.6 V			±1		±5		±20	μA
I _{CC}	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6 V			1		10		40	μA
ΔI _{CC}	One input at $V_{CC} - 0.6 V$, Other inputs at V_{CC} or GND	2.7 V to 3.6 V			500		500		5000	μA
Ci	$V_{I} = V_{CC} \text{ or } GND$	3.3 V		5						pF

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7.8 Switching Characteristics, SN54LVC00A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 2)

				SN54LVC00A	
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{cc}	–55°C to 125°C	UNIT
	(MIN MAX	
	A or D	V	2.7 V	5.1	
t _{pd}	A or B	ř	$3.3 \text{ V} \pm 0.3 \text{ V}$	1 4.3	ns

7.9 Switching Characteristics, SN74LVC00A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 2)

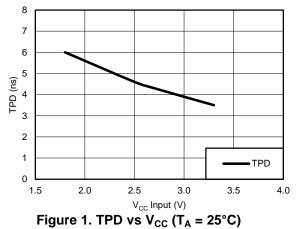
							SN74L	/C00A			
PARAMETER (INPUT)	FROM (INPUT)	TO (OUTPUT)	V _{cc}	Τ,	T _A = 25°C			o 85°C	–40°C to	125°C	UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX		
			1.8 V ± 0.15 V	1	6	12	1	12.5	1	14	
	A or B	V	2.5 V ± 0.2 V	1	4.6	5.9	1	6.4	1	7.9	20
t _{pd}	AUD	ř	2.7 V	1	4.3	4.9	1	5.1	1	6.5	ns
			$3.3 \text{ V} \pm 0.3 \text{ V}$	1	3.5	4.1	1	4.3	1	5.5	
t _{sk(o)}			$3.3 \text{ V} \pm 0.3 \text{ V}$					1		1.5	ns

7.10 Operating Characteristics

 $T_A = 25^{\circ}C$

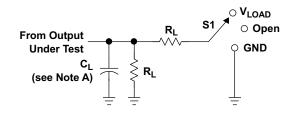
	PARAMETER	TEST CONDITIONS	V _{cc}	TYP	UNIT
			1.8 V	18	
C _{pd}	Power dissipation capacitance per gate	f = 10 MHz	2.5 V	18	pF
			3.3 V	19	

7.11 Typical Characteristics



VI

8 Parameter Measurement Information



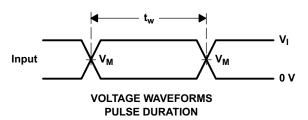
LOAD CIRCUIT

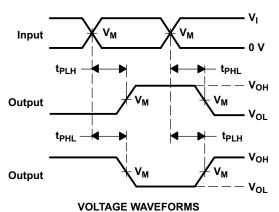
TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	V _{LOAD}
t _{PHZ} /t _{PZH}	GND

Vм

	INF	PUTS			•	1	
V _{CC}	vı	t _r /t _f	VM	V _{LOAD}	CL	RL	ν _Δ
1.8 V ± 0.15 V	V _{cc}	≤2 ns	V _{CC} /2	2 × V _{CC}	30 pF	1 kΩ	0.15 V
$2.5 V \pm 0.2 V$	V _{CC}	≤2 ns	V _{CC} /2	2 × V _{CC}	30 pF	500 Ω	0.15 V
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
3.3 V ± 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V

Timing Input





0 V t_{su} th ٧ı Vм Data Input Vм ΛV **VOLTAGE WAVEFORMS** SETUP AND HOLD TIMES VI Output Vм Vм Control 0 V t_{PZL} t_{PLZ} Output V_{LOAD}/2 Waveform 1 S1 at VLOAD ٧м V_{OL} + V_A (see Note B) VoL t_{PH7} t_{PZH} Output V_{OH} Waveform 2 V_{OH} – V_∆ VM S1 at GND ≈0 V (see Note B) VOLTAGE WAVEFORMS **ENABLE AND DISABLE TIMES** LOW- AND HIGH-LEVEL ENABLING

INVERTING AND NONINVERTING OUTPUTS

PROPAGATION DELAY TIMES

NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR ≤10 MHz, Z_O = 50 Ω.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. t_{PLH} and t_{PHL} are the same as t_{pd} .
- H. All parameters and waveforms are not applicable to all devices.

Figure 2. Load Circuit and Voltage Waveforms

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9 Detailed Description

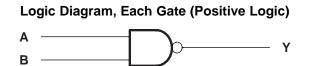
9.1 Overview

The maximum sink and source current is 24mA.

Inputs can be driven from 1.8-V, 2.5-V, 3.3-V (LVTTL), or 5-V (CMOS) devices. This feature allows the use of this device as translators in a mixed-system environment.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

9.2 Functional Block Diagram



9.3 Feature Description

- Wide operating voltage range
 - Operates from 1.65 V to 3.6 V
- Allows up or down voltage translation
- Inputs and outputs accept voltages to 5.5 V
- I_{off} feature
 - Allows voltages on the inputs and outputs when V_{CC} is 0 V

9.4 Device Functional Modes

	Table 1. Function Table (Each Gate)									
INP	INPUTS OUTPUT									
Α	В	Y								
Н	Н	L								
L	Х	Н								
Х	L	н								

NSTRUMENTS

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10 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

SN74LVC00A is a high-drive CMOS device that can be used for a multitude of buffer-type functions. It can produce 24 mA of drive current at 3.3 V. Therefore, this device is ideal for driving multiple inputs and for high-speed applications up to 100 MHz. The inputs and outputs are 5.5-V tolerant allowing the device to translate up to 5.5 V or down to V_{CC} .

10.2 Typical Application

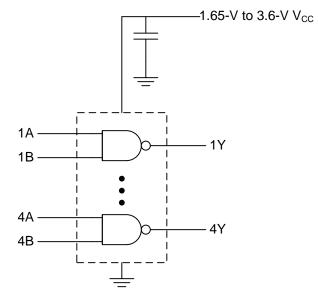


Figure 3. Typical NAND Gate Application and Supply Voltage

10.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads; therefore, routing and load conditions should be considered to prevent ringing.

10.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions
 - Rise time and fall time specs: See ($\Delta t/\Delta V$) in the *Recommended Operating Conditions, SN74LVC00A* table.
 - Specified high and low levels: See (V_{IH} and V_{IL}) in the *Recommended Operating Conditions,* SN74LVC00A table.
 - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V_{CC} .
- 2. Recommend Output Conditions
 - Load currents should not exceed 25 mA per output and 50 mA total for the part.
 - Outputs should not be pulled above 5.5 V.



Typical Application (continued)

10.2.3 Application Curves

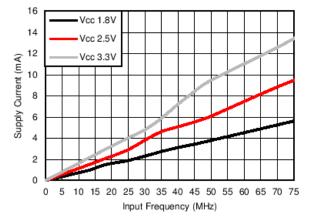


Figure 4. I_{CC} vs Frequency

11 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the *Recommended Operating Conditions, SN74LVC00A* table.

Each V_{CC} pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1 μ F is recommended; if there are multiple V_{CC} pins, then 0.01 μ F or 0.022 μ F is recommended for each power pin. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. A 0.1 μ F and a 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

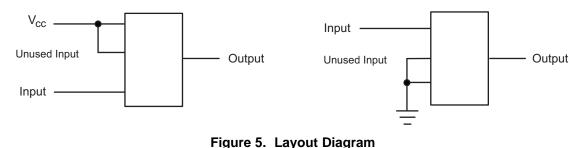
12 Layout

12.1 Layout Guidelines

When using multiple bit logic devices inputs should never float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Layout Example specifies the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} , whichever makes more sense or is more convenient. It is generally acceptable to float outputs, unless the part is a transceiver.

12.2 Layout Example



13 Device and Documentation Support

13.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
SN54LVC00A	Click here	Click here	Click here	Click here	Click here
SN74LVC00A	Click here	Click here	Click here	Click here	Click here

Table 2. Related Links

13.2 Trademarks

All trademarks are the property of their respective owners.

13.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

13.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9753301Q2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9753301Q2A SNJ54LVC 00AFK	Samples
5962-9753301QCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9753301QC A SNJ54LVC00AJ	Samples
5962-9753301QDA	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9753301QD A SNJ54LVC00AW	Samples
5962-9753301VDA	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9753301VD A SNV54LVC00AW	Samples
SN74LVC00AD	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC00A	Samples
SN74LVC00ADBR	ACTIVE	SSOP	DB	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC00A	Samples
SN74LVC00ADBRG4	ACTIVE	SSOP	DB	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC00A	Samples
SN74LVC00ADE4	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC00A	Samples
SN74LVC00ADR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC00A	Samples
SN74LVC00ADRG4	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC00A	Samples
SN74LVC00ADT	ACTIVE	SOIC	D	14	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC00A	Samples
SN74LVC00ANSR	ACTIVE	SO	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC00A	Samples
SN74LVC00ANSRG4	ACTIVE	SO	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC00A	Samples
SN74LVC00APW	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC00A	Samples
SN74LVC00APWE4	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC00A	Samples
SN74LVC00APWG4	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC00A	Samples
SN74LVC00APWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	LC00A	Samples



Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
SN74LVC00APWRE4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC00A	Samples
SN74LVC00APWRG4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC00A	Samples
SN74LVC00APWT	ACTIVE	TSSOP	PW	14	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC00A	Samples
SN74LVC00ARGYR	ACTIVE	VQFN	RGY	14	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	LC00A	Samples
SNJ54LVC00AFK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9753301Q2A SNJ54LVC 00AFK	Samples
SNJ54LVC00AJ	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9753301QC A SNJ54LVC00AJ	Samples
SNJ54LVC00AW	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9753301QD A SNJ54LVC00AW	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



PACKAGE OPTION ADDENDUM

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN54LVC00A, SN54LVC00A-SP, SN74LVC00A :

- Catalog : SN74LVC00A, SN54LVC00A
- Automotive : SN74LVC00A-Q1, SN74LVC00A-Q1
- Enhanced Product : SN74LVC00A-EP, SN74LVC00A-EP
- Military : SN54LVC00A
- Space : SN54LVC00A-SP

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications
- Military QML certified for Military and Defense Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application

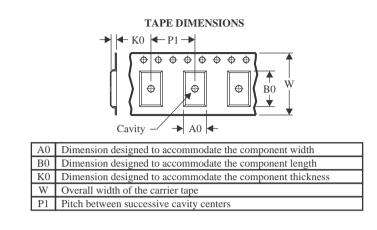


Texas

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVC00ADBR	SSOP	DB	14	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74LVC00ADR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74LVC00ADT	SOIC	D	14	250	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74LVC00ANSR	SO	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74LVC00APWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LVC00APWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LVC00APWT	TSSOP	PW	14	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LVC00ARGYR	VQFN	RGY	14	3000	330.0	12.4	3.75	3.75	1.15	8.0	12.0	Q1



PACKAGE MATERIALS INFORMATION

8-Dec-2023



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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVC00ADBR	SSOP	DB	14	2000	356.0	356.0	35.0
SN74LVC00ADR	SOIC	D	14	2500	340.5	336.1	32.0
SN74LVC00ADT	SOIC	D	14	250	210.0	185.0	35.0
SN74LVC00ANSR	SO	NS	14	2000	356.0	356.0	35.0
SN74LVC00APWR	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74LVC00APWRG4	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74LVC00APWT	TSSOP	PW	14	250	356.0	356.0	35.0
SN74LVC00ARGYR	VQFN	RGY	14	3000	356.0	356.0	35.0

TEXAS INSTRUMENTS

www.ti.com

8-Dec-2023

TUBE



- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
5962-9753301Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9753301QDA	W	CFP	14	25	506.98	26.16	6220	NA
5962-9753301VDA	W	CFP	14	25	506.98	26.16	6220	NA
SN74LVC00AD	D	SOIC	14	50	506.6	8	3940	4.32
SN74LVC00ADE4	D	SOIC	14	50	506.6	8	3940	4.32
SN74LVC00APW	PW	TSSOP	14	90	530	10.2	3600	3.5
SN74LVC00APWE4	PW	TSSOP	14	90	530	10.2	3600	3.5
SN74LVC00APWG4	PW	TSSOP	14	90	530	10.2	3600	3.5
SNJ54LVC00AFK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54LVC00AW	W	CFP	14	25	506.98	26.16	6220	NA

MECHANICAL DATA



- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- earrow Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated.
- The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



RGY (S-PVQFN-N14)

PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: All linear dimensions are in millimeters





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.

D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com.

- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



MECHANICAL DATA

PLASTIC SMALL-OUTLINE PACKAGE

0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 \bigcirc Gage Plane ₽ 0,25 7 1 1,05 0,55 0-10 Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS ** 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G**)

14-PINS SHOWN

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



W (R-GDFP-F14)

CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. This package can be hermetically sealed with a ceramic lid using glass frit.
 - D. Index point is provided on cap for terminal identification only.
 - E. Falls within MIL STD 1835 GDFP1-F14



FK 20

8.89 x 8.89, 1.27 mm pitch

GENERIC PACKAGE VIEW

LCCC - 2.03 mm max height

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





GENERIC PACKAGE VIEW

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



J0014A



PACKAGE OUTLINE

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



NOTES:

- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
 Falls within MIL-STD-1835 and GDIP1-T14.



J0014A

EXAMPLE BOARD LAYOUT

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE





D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



A. An integration of the information o

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



MECHANICAL DATA

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



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